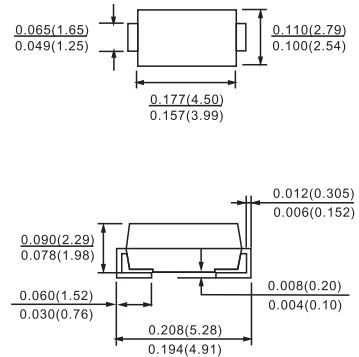


FEATURES

- Glass passivated
- High maximum operating temperature
- Low leakage current
- Excellent stability
- Guaranteed avalanche energy absorption capability
- UL 94V-O classified plastic package
- Shipped in 12 mm embossed tape.

DO-214AC(SMA)



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--------------------|-------------------------------------|--|------|------|------|
| V _{RRM} | repetitive peak reverse voltage | | | | |
| | BYG50D | | - | 200 | V |
| | BYG50G | | - | 400 | V |
| | BYG50J | | - | 600 | V |
| | BYG50K | | - | 800 | V |
| | BYG50M | | - | 1000 | V |
| V _R | continuous reverse voltage | | | | |
| | BYG50D | | - | 200 | V |
| | BYG50G | | - | 400 | V |
| | BYG50J | | - | 600 | V |
| | BYG50K | | - | 800 | V |
| | BYG50M | | - | 1000 | V |
| I _{F(AV)} | average forward current | averaged over any 20 ms period; T _{tp} = 100 °C; see Fig.2 | - | 2.1 | A |
| | | averaged over any 20 ms period; Al ₂ O ₃ PCB mounting (see Fig.7); T _{amb} = 60 °C; see Fig.3 | - | 1.0 | A |
| | | averaged over any 20 ms period; epoxy PCB mounting (see Fig.7); T _{amb} = 60 °C; see Fig.3 | - | 0.7 | A |
| I _{FSM} | non-repetitive peak forward current | t = 10 ms half sinewave; T _j = T _{jmax} prior to surge; V _R = V _{RRMmax} | - | 30 | A |

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|--|---|------|------|------|
| E _{RSM} | non-repetitive peak reverse avalanche energy | L = 120 mH; T _j = T _{j max} prior to surge; inductive load switched off | | | |
| | BYG50D to J | | – | 10 | mJ |
| | BYG50K and M | | – | 7 | mJ |
| T _{stg} | storage temperature | | –65 | +175 | °C |
| T _j | junction temperature | see Fig.4 | –65 | +175 | °C |

ELECTRICAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT | |
|--------------------|-------------------------------------|---|--------|------|------|------|---|
| V _F | forward voltage | I _F = 1 A; T _j = T _{j max} ; see Fig.5 | – | – | 0.85 | V | |
| | | I _F = 1 A; see Fig.5 | – | – | 1.00 | V | |
| V _{(BR)R} | reverse avalanche breakdown voltage | I _R = 0.1 mA | | | | | |
| | | | BYG50D | 300 | – | – | V |
| | | | BYG50G | 500 | – | – | V |
| | | | BYG50J | 700 | – | – | V |
| | | | BYG50K | 900 | – | – | V |
| | BYG50M | 1100 | – | – | V | | |
| I _R | reverse current | V _R = V _{RRMmax} ; see Fig.6 | – | – | 1 | μA | |
| | | V _R = V _{RRMmax} ; T _j = 165 °C; see Fig.6 | – | – | 100 | μA | |
| t _{rr} | reverse recovery time | when switched from I _F = 0.5 A to I _R = 1 A; measured at I _R = 0.25 A; see Fig.8 | – | 2 | – | μs | |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|----------------------|---|------------|-------|------|
| R _{th j-tp} | thermal resistance from junction to tie-point | | 25 | K/W |
| R _{th j-a} | thermal resistance from junction to ambient | note 1 | 100 | K/W |
| | | note 2 | 150 | K/W |

Notes

1. Device mounted on Al₂O₃ printed-circuit board, 0.7 mm thick; thickness of copper ≥35 μm, see Fig.7.
2. Device mounted on epoxy-glass printed-circuit board, 1.5 mm thick; thickness of copper ≥40 μm, see Fig.7.
For more information please refer to the "General Part of associated Handbook".

RATINGS AND CHARACTERISTIC CURVES

BYG50D THRU BYG50M

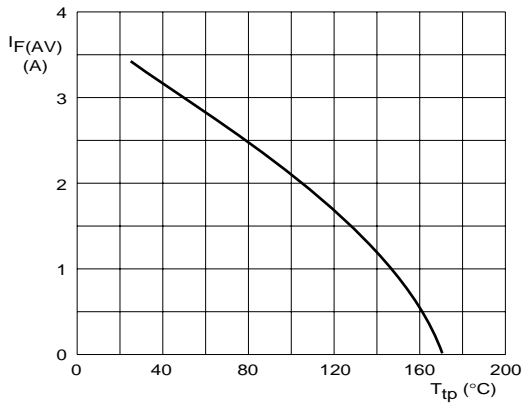


Fig.1 Maximum permissible average forward current as a function of tie-point temperature

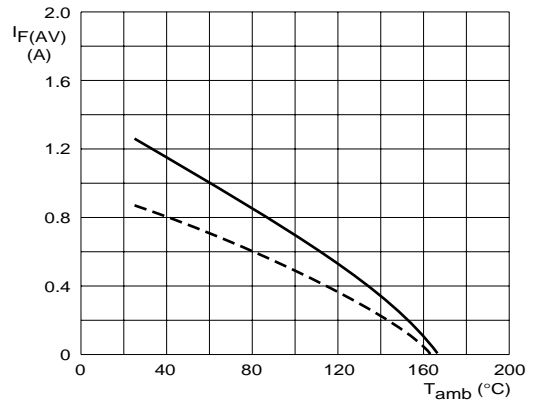


Fig.2 Maximum permissible average forward current as a function of ambient temperature

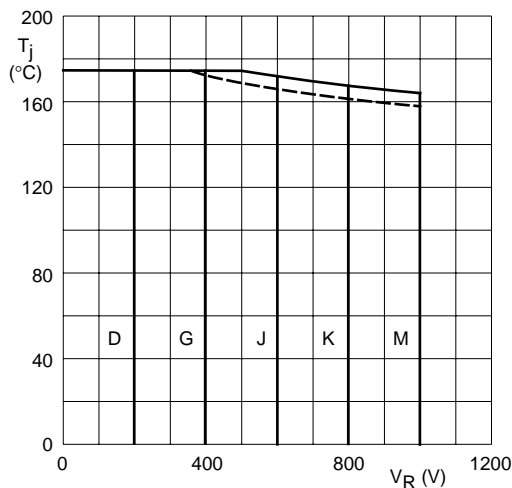


Fig.3 Maximum permissible junction temperature as a function of reverse voltage.

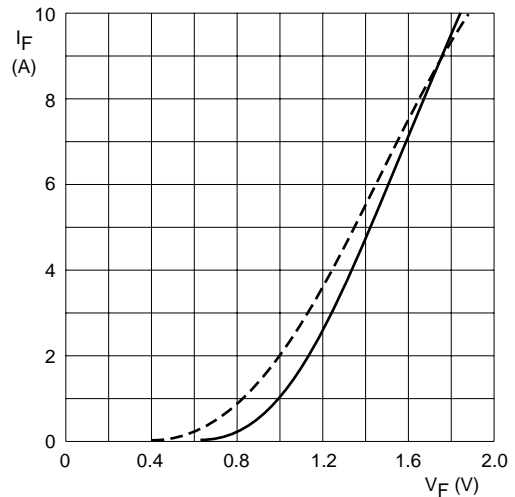


Fig. 4 Forward current as a function of forward voltage; maximum values.

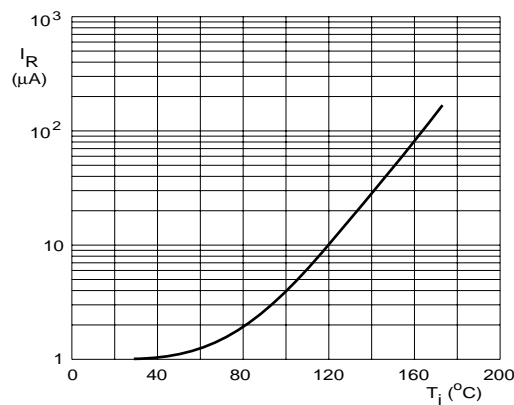


Fig.5 Reverse current as a function of junction temperature; maximum values.